

74F2240 Octal Buffer/Line Driver with 25Ω Series Resistors in the Outputs

General Description

The 74F2240 is an inverting octal buffer and line driver designed to drive capacitive inputs of MOS memory devices, address and clock lines or act as a low undershoot general purpose bus driver.

The 25Ω series resistor in the outputs reduces undershoot and ringing and eliminates the need for external resistors.

Features

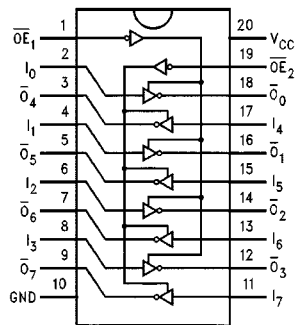
- 3-STATE outputs drive bus lines or buffer memory address registers
- Outputs sink 12 mA and source 15 mA
- 25Ω series resistors in outputs eliminate the need for external resistors
- Designed to drive the capacitive inputs of MOS devices
- Guaranteed 4000V minimum ESD protection

Ordering Code:

| Order Number | Package Number | Package Description |
|--------------|----------------|---|
| 74F2240SC | M20B | 20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide |
| 74F2240QC | V20A | 20-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.350 Square |

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram



Truth Table

| \overline{OE}_1 | D_{1n} | O_{1n} | \overline{OE}_2 | D_{2n} | O_{2n} |
|-------------------|----------|----------|-------------------|----------|----------|
| H | X | Z | H | X | Z |
| L | H | L | L | H | L |
| L | L | H | L | L | H |

Unit Loading/Fan Out

| Pin Names | Description | U.L. HIGH/LOW | Output I_{OH}/I_{OL} |
|------------------------------------|--|---------------|------------------------|
| $\overline{OE}_1, \overline{OE}_2$ | 3-STATE Output Enable Input (Active LOW) | 1.0/1.667 | 20 μ A/-1 mA |
| $I_0 - I_7$ | Inputs | 1.0/1.667 | 20 μ A/-1 mA |
| $\overline{O}_0 - \overline{O}_7$ | Outputs | 750/20 | -15 mA/12 mA |

Absolute Maximum Ratings (Note 1)

| | |
|---|--------------------------------------|
| Storage Temperature | -65°C to +150°C |
| Ambient Temperature under Bias | -55° to +125°C |
| Junction Temperature under Bias | -55°C to +150°C |
| V _{CC} Pin Potential to Ground Pin | -0.5V to +7.0V |
| Input Voltage (Note 2) | -0.5V to +7.0V |
| Input Current (Note 2) | -30 mA to +5.0 mA |
| Voltage Applied to Output | |
| In HIGH State (with V _{CC} = 0V) | |
| Standard Output | -0.5V to V _{CC} |
| 3-STATE Output | -0.5V to +5.5V |
| Current Applied to Output | |
| in LOW State (Max) | twice the rated I _{OL} (mA) |
| ESD Last Passing Voltage (Min) | 4000V |

Recommended Operating Conditions

| | |
|------------------------------|----------------|
| Free Air Ambient Temperature | 0°C to 70°C |
| Supply Voltage | +4.5V to +5.5V |

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

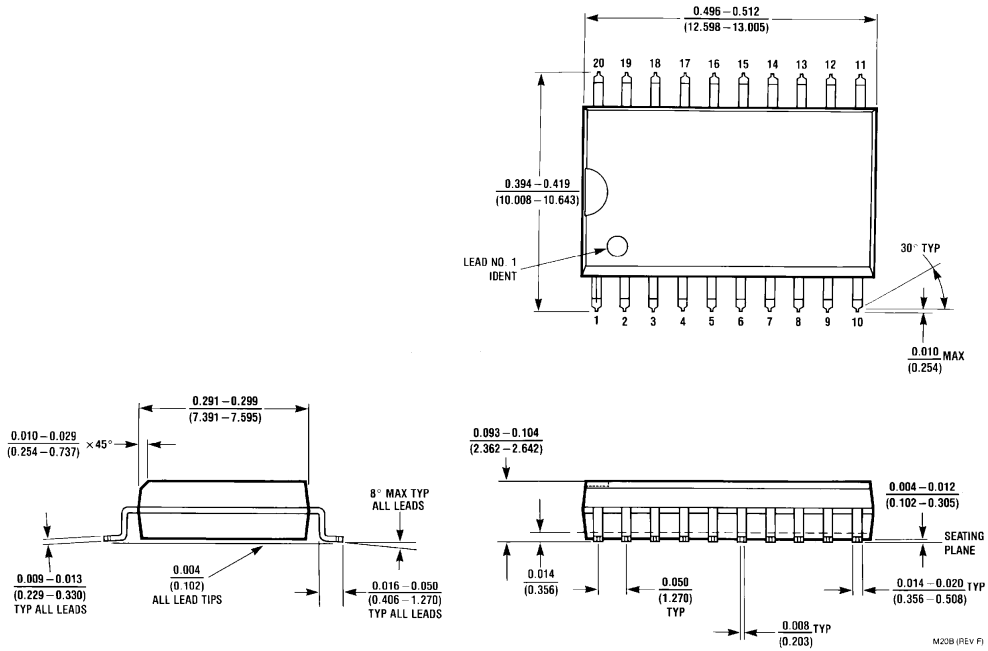
DC Electrical Characteristics

| Symbol | Parameter | Min | Typ | Max | Units | V _{CC} | Conditions |
|------------------|-----------------------------------|---------------------|-----|------|-------|-----------------|---|
| V _{IH} | Input HIGH Voltage | 2.0 | | | V | | Recognized as a HIGH Signal |
| V _{IL} | Input LOW Voltage | | | 0.8 | V | | Recognized as a LOW Signal |
| V _{CD} | Input Clamp Diode Voltage | | | -1.2 | V | Min | I _{IN} = -18 mA |
| V _{OH} | Output HIGH Voltage | 10% V _{CC} | 2.4 | | V | Min | I _{OH} = -3 mA |
| | Voltage | 10% V _{CC} | 2.0 | | | | I _{OH} = -15 mA |
| V _{OL} | Output LOW Voltage | 10% V _{CC} | | 0.75 | V | Min | I _{OL} = 12 mA |
| I _{IH} | Input HIGH Current | | | 5.0 | μA | Max | V _{IN} = 2.7V |
| I _{BVI} | Input HIGH Current Breakdown Test | | | 7.0 | μA | Max | V _{IN} = 7.0V |
| I _{CEX} | Output HIGH Leakage Current | | | 50 | μA | Max | V _{OUT} = V _{CC} |
| V _{ID} | Input Leakage Test | 4.75 | | | V | 0.0 | I _{ID} = 1.9 μA All Other Pins Grounded |
| I _{OD} | Output Leakage Circuit Current | | | 3.75 | μA | 0.0 | V _{IOD} = 150 mV All Other Pins Grounded |
| I _{IL} | Input LOW Current | | | -1.0 | mA | Max | V _{IN} = 0.5V (OE ₁ , OE ₂ , D _n) |
| I _{OZH} | Output Leakage Current | | | 50 | μA | Max | V _{OUT} = 2.7V |
| I _{OZL} | Output Leakage Current | | | -50 | μA | Max | V _{OUT} = 0.5V |
| I _{OS} | Output Short-Circuit Current | -100 | | -225 | mA | Max | V _{OUT} = 0V |
| I _{ZZ} | Bus Drainage Test | | | 500 | μA | 0.0 | V _{OUT} = 5.25V |
| I _{CCH} | Power Supply Current | | 16 | 29 | mA | Max | V _O = HIGH |
| I _{CCL} | Power Supply Current | | 47 | 75 | mA | Max | V _O = LOW |
| I _{CCZ} | Power Supply Current | | 45 | 63 | mA | Max | V _O = HIGH Z |

AC Electrical Characteristics

| Symbol | Parameter | T _A = +25°C V _{CC} = +5.0V C _L = 50 pF | | | T _A = 0°C to +70°C V _{CC} = +5.0V C _L = 50 pF | | Units |
|------------------|---------------------|---|-----|-----|--|------|-------|
| | | Min | Typ | Max | Min | Max | |
| t _{PLH} | Propagation Delay | 3.0 | 4.9 | 7.5 | 3.0 | 7.5 | ns |
| t _{PHL} | Data to Output | 2.0 | 3.7 | 6.0 | 2.0 | 6.0 | |
| t _{PZH} | Output Enable Time | 2.0 | 3.9 | 6.5 | 2.0 | 7.0 | ns |
| t _{PZL} | | 4.0 | 6.7 | 9.5 | 4.0 | 10.0 | |
| t _{PHZ} | Output Disable Time | 2.0 | 4.1 | 6.5 | 2.0 | 7.0 | ns |
| t _{PLZ} | | 2.0 | 4.9 | 8.5 | 2.0 | 9.5 | |

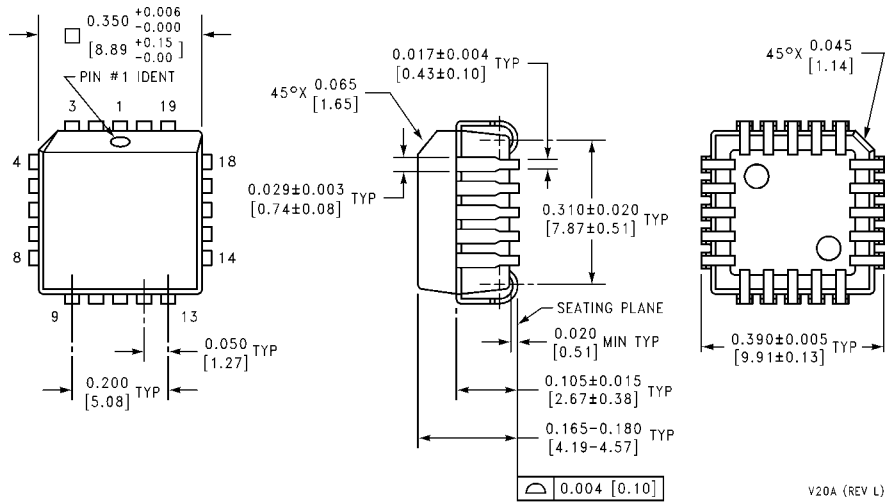
Physical Dimensions inches (millimeters) unless otherwise noted



**20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
Package Number M20B**

M20B (REV F)

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**20-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.350 Square
Package Number V20A**

V20A (REV L)

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